

High Resolution Optical Reflective Sensor

Technical Data

Features

- Focused Emitter and Detector in a Single Package
- High Resolution-0.190 mm Spot Size
- 700 nm Visible Emitter
- Lens Filtered to Reject Ambient Light
- TO-5 Miniature Sealed Package
- Photodiode and Transistor Output
- Solid State Reliability

Description

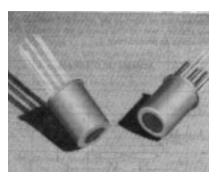
The HBCS-1100 is a fully integrated module designed for optical reflective sensing. The module contains a 0.178 mm (0.007 in.) diameter 700 nm visible LED emitter and a

matched I.C. photodetector. A bifurcated aspheric lens is used to image the active areas of the emitter and the detector to a single spot 4.27 mm (0.168 in.) in front of the package. The reflected signal can be sensed directly from the photodiode or through an internal transistor that can be configured as a high gain amplifier.

Applications

Applications include pattern recognition and verification, object sizing, optical limit switching, tachometry, textile thread counting and defect detection, dimensional monitoring, line locating, mark, and bar code scanning, and paper edge detection.

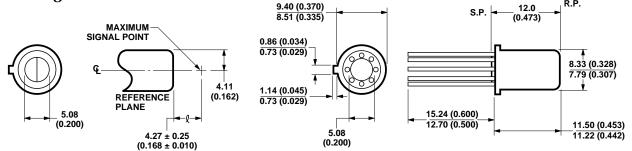
HBCS-1100



Mechanical Considerations

The HBCS-1100 is packaged in a high profile 8 pin TO-5 metal can with a glass window. The emitter and photodetector chips are mounted on the header at the base of the package. Positioned above these active elements is a bifurcated aspheric acrylic lens that focuses them to the same point.

Package Dimensions



NOTES:

- 1. ALL DIMENSIONS IN MILLIMETERS AND (INCHES).
- 2. ALL UNTOLERANCED DIMENSIONS ARE FOR REFERENCE ONLY.
- 3. THE REFERENCE PLANE IS THE TOP SURFACE OF THE PACKAGE.
- 4. NICKEL CAN AND GOLD PLATED LEADS.
- 5. S.P. SEATING PLANE.
- 6. THE LEAD DIAMETER IS 0.45 mm (0.018 IN.) TYP.

The sensor can be rigidly secured by commercially available two piece TO-5 style heat sinks, such as Thermalloy 2205, or Aavid Engineering 3215. These fixtures provide a stable reference platform and their tapped mounting holes allow for ease of affixing this assembly to the circuit board.

Electrical Operation

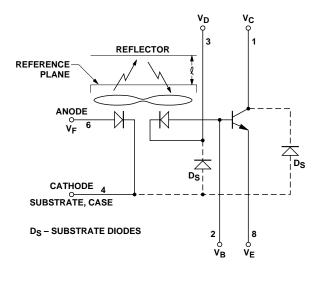
The detector section of the sensor can be connected as a single photodiode or as a photodiode transistor amplifier. When photodiode operation is desired, it is recommended that the substrate diodes be defeated by connecting the collector of the

transistor to the positive potential of the power supply and shorting the base-emitter junction of the transistor. Figure 15 shows photocurrent being supplied from the anode of the photodiode to an inverting input of the operational amplifier. The circuit is recommended to improve the reflected photocurrent to stray photocurrent ratio by keeping the substrate diodes from acting as photodiodes.

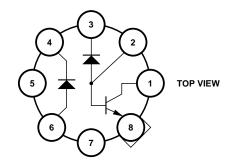
The cathode of the 700 nm emitter is physically and electrically connected to the casesubstrate of the device. Applications that require modulation or switching of the LED should be designed to have the cathode connected to the electrical ground of the system. This insures minimum capacitive coupling of the switching transients through the substrate diodes to the detector amplifier section.

The HBCS-1100 detector also includes an NPN transistor which can be used to increase the output current of the sensor. A current feedback amplifier as shown in Figure 6 provides moderate current gain and bias point stability.

Schematic Diagram



Connection Diagram



PIN	FUNCTION
1	TRANSISTOR COLLECTOR
2	TRANSISTOR BASE, PHOTODIODE ANODE
3	PHOTODIODE CATHODE
4	LED CATHODE, SUBSTRATE, CASE
5	NC
6	LED ANODE
7	NC
8	TRANSISTOR EMITTER

CAUTION: The small junction sizes inherent to the design of this bipolar component increase the component's susceptibility to damage from electrostatic discharge (ESD). It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be introduced by ESD.

Absolute Maximum Ratings at $T_A = 25^{\circ}C$

Parameter	Symbol	Min.	Max.	Units	Fig.	Notes
Storage Temperature	T_{S}	-40	+75	$^{\circ}\mathrm{C}$		
Operating Temperature	TA	-20	+70	°C		
Lead Soldering Temperature 1.6 mm from Seating Plane			260 for 10 sec.	°C		11
Average LED Forward Current	I_{F}		50	mA		2
Peak LED Forward Current	I_{FPK}		75	mA	1	1
Reverse LED Input Voltage	$V_{ m R}$		5	V		
Package Power Dissipation	P _P		120	mW		3
Collector Output Current	Io		8	mA		
Supply and Output Voltage	$V_{\rm D},V_{\rm C},V_{\rm E}$	-0.5	20	V		10
Transistor Base Current	I_{B}		5	mA		
Transistor Emitter Base Voltage	V_{EB}		0.5	V		

System Electrical/Optical Characteristics at $T_A = 25^{\circ}C$

Parameter	Symbol	Min.	Typ.	Max.	Units	Conditions	Fig.	Note
Total Photocurrent	I_P			575	nA	$T_{A} = 20^{\circ}C \mid I_{F} = 35 \text{ mA},$	2, 3	4
$(I_{PR} + I_{PS})$		150	250	375		$T_A = 25$ °C $V_D = V_C = 5 \text{ V}$	15	
		80				$T_A = 70^{\circ}C$		
Reflected Photocurrent	I_{PR}	4	8.5			$I_F = 35 \text{ mA},$	3	
(I _{PR}) to Internal Stray	$\overline{ m I}_{ m PS}$					$V_C = V_D = 5 V$		
Photocurrent (I _{PS})								
Transistor DC Static	h_{FE}	50				$T_A = 20$ °C $V_{CE} = 5 V$,	4, 5	
Current Transfer Ratio		100	200			$T_{A} = 25^{\circ}C$ $I_{C} = 10 \mu A$		
Slew Rate			0.08		V/μs	$R_L = 100 \text{ K}, I_{PK} = 50 \text{ mA},$	6	
						$R_F = 10 \text{ M}, t_{ON} = 100 \mu s,$		
						Rate = 1 kHz		
Image Diameter	d		0.17		mm	$I_F = 35 \text{ mA},$	8, 10	8, 9
						$\ell = 4.27 \text{ mm } (0.168 \text{ in.})$		
Maximum Signal Point	l	4.01	4.27	4.52	mm	Measured from Reference	9	
						Plane		
50% Modulation	MTF		2.5		I _{npr/mm}	$I_{\underline{F}} = 35 \text{ mA},$	10,	5, 7
Transfer Function						ℓ =4.27 mm	11	
Depth of Focus	$\Delta \mathcal{L}$		1.2		mm	50% of I _P at ℓ = 4.27 mm	9	5
	FWHM							
Effective Numerical	N.A.		0.3					
Aperture								
Image Location	D		0.51		mm	Diameter Reference to		6
						Centerline		
						ℓ = 4.27 mm		
Thermal Resistance	$\Theta_{ m JC}$		85		°C/W			

Detector Electrical/Optical Characteristics at $T_A = 25$ °C

Parameter	Symbol	Min.	Typ.	Max.	Units	Conditions		Fig.	Note
Dark Current	I_{PD}		5	200	pA	$T_A = 25$ °C $I_F = 0, V_D = 5 V;$			
				10	nA	$T_A = 70$ °C Reflection = 0%			
Capacitance	C_{D}		45		pF	$V_D = 0 \text{ V}, I_P = 0, f = 1 \text{ MHz}$			
Flux Responsivity	Rφ		0.22		A/W	$\lambda = 700 \text{ nm}, V_D = 5 \text{ V}$		12	
Detector Area	A_{D}		0.160		mm^2	Square, with			
						Length = 0.4 mm/Side			

Emitter Electrical/Optical Characteristics at $T_A = 25^{\circ}C$

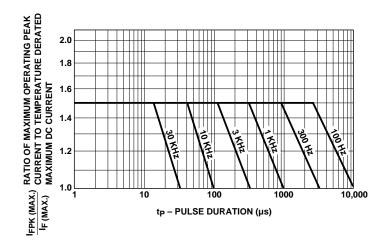
Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions	Fig.	Note
Forward Voltage	$V_{ m F}$		1.6	1.8	V	$I_F = 35 \text{ mA}$	13	
Reverse Breakdown Voltage	BV_R	5			V	$I_{R} = 100 \ \mu A$		
Radiant Flux	$\phi_{ m E}$	5	9.0		μW	$I_{\rm F} = 35 \text{ mA},$	14	
						$\lambda = 700 \text{ nm}$		
Peak Wavelength	$\lambda_{ m p}$	680	700	720	nm	$I_F = 35 \text{ mA}$	14	
Thermal Resistance	$\Theta_{ m JC}$		150	·	°C/W			
Temperature Coefficient of V _F	$\Delta V_F/\Delta T$		-1.2		mV/°C	$I_F = 35 \text{ mA}$		

Transistor Electrical Characteristics at T_A = 25°C

Parameter	Symbol	Min.	Тур.	Max.	Units	Conditions	Fig.	Note
Collector-Emitter Leakage	I_{CEO}		1		nA	$V_{CE} = 5 \text{ V}$		
Base-Emitter Voltage	$V_{ m BE}$		0.6		V	$I_{\rm C} = 10 \mu\text{A}, I_{\rm B} = 70 \text{nA}$		
Collector-Emitter Saturation	V _{CE} (SAT)		0.4		V	$I_{\rm B} = 1~\mu {\rm A}, I_{\rm E} = 10~\mu {\rm A}$		
Voltage								
Collector-Base Capacitance	C_{CB}		0.3		pF	$f = 1$ MHz, $V_{CB} = 5$ V		
Base-Emitter Capacitance	C_{BE}		0.4		pF	$f = 1 \text{ MHz}, V_{BE} = 0 \text{ V}$		
Thermal Resistance	$\Theta_{ m JC}$		200		°C/W			

Notes

- 1. 300 μs pulse width, 1 kHz pulse rate.
- 2. Derate Maximum Average Current linearly from $65\,^{\circ}\!\mathrm{C}$ by 6 mA/°C.
- 3. Without heat sinking from $T_A = 65\,^{\circ}\mathrm{C}$, derate Maximum Average Power linearly by 12 mW/°C.
- 4. Measured from a reflector coated with a 99% reflective white paint (Kodak 6080) positioned 4.27 mm (0.168 in.) from the reference plane.
- 5. Peak-to-Peak response to black and white bar patterns.
- 6. Center of maximum signal point image lies within a circle of diameter D relative to the center line of the package. A second emitter image (through the detector lens) is also visible. This image does not affect normal operation.
- 7. This measurement is made with the lens cusp parallel to the black-white transition.
- 8. Image size is defined as the distance for the 10%-90% response as the sensor moves over an abrupt black-white edge.
- $9. \ (+)$ indicates an increase in the distance from the reflector to the reference plane.
- $10. \ {\rm All} \ {\rm voltages} \ {\rm referenced} \ {\rm to} \ {\rm Pin} \ 4.$
- 11. CAUTION: The thermal constraints of the acrylic lens will not permit the use of conventional wave soldering procedures. The typical preheat and post cleaning temperatures and dwell times can subject the lens to thermal stresses beyond the absolute maximum ratings and can cause it to defocus.



 $\begin{tabular}{ll} Figure 1. Maximum Tolerable Peak Current vs. Pulse \\ Duration. \end{tabular}$

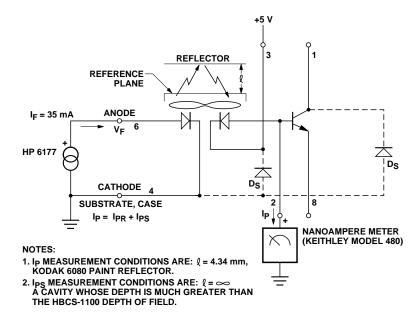


Figure 3. I_P Test Circuit.

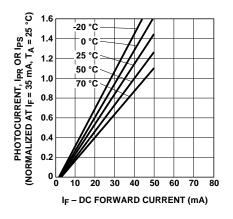
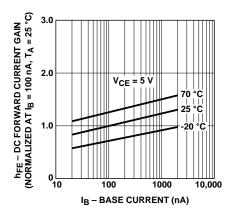


Figure 2. Relative Total Photocurrent vs. LED DC Forward Current.



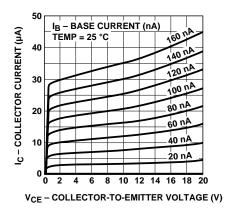


Figure 4. Normalized Transistor DC Forward Current Gain vs. Base Current at Temperature.

Figure 5. Common Emitter Collector Characteristics.

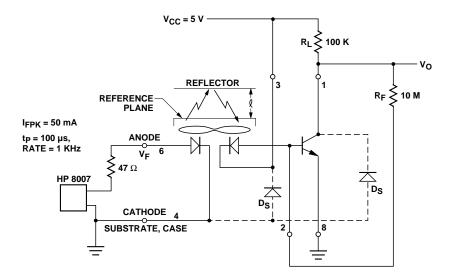


Figure 6. Slew Rate Measurement Circuit.

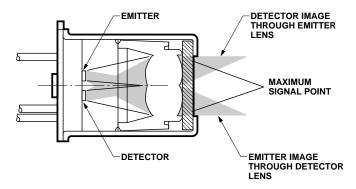
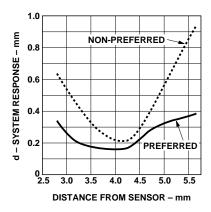
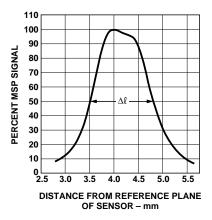


Figure 7. Image Location.





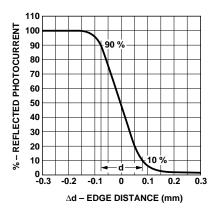
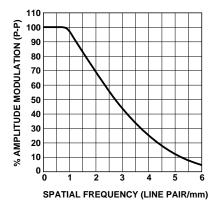
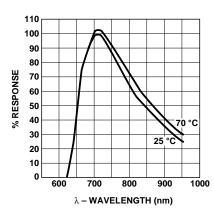


Figure 8. Image Size vs. Distance from Sensor.

Figure 9. Reflector Distance vs. Percent Reflected Photocurrent.

Figure 10. Step Edge Response.





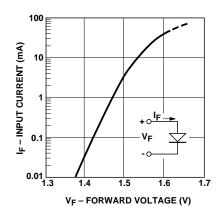
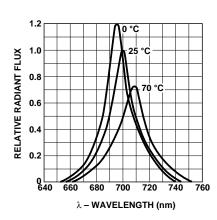


Figure 11. Modulation Transfer Function.

Figure 12. Detector Spectral Response.

Figure 13. LED Forward Current vs. Forward Voltage Characteristics.





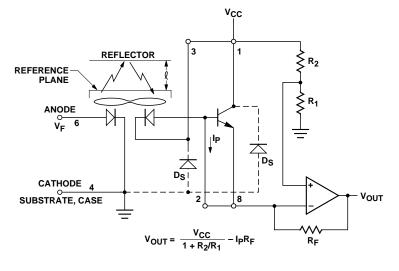


Figure 15. Photodiode Interconnection.

